

# Quiz 1 and Final Project, Hyperexponential Distributions

ECE 313

Probability with Engineering Applications

Lecture 22

Professor Ravi K. Iyer

Dept. of Electrical and Computer Engineering

University of Illinois at Urbana Champaign

# Today's Topics

- **Quiz 1**
- **Final Project**
- **Review:**
  - **Hypoexponential** Distribution
  - Erlang and Gamma Distributions
- **Hyperexponential** Distribution

# Final Project

- Pick an example system that you want to measure and characterize its reliability or performance. For example:
  - Software-as-a-Service (SaaS) Business System (Mini Project 1)
  - Patient Monitoring System (Mini Project 2)
  - Blue Waters Supercomputers
  - Your own PC or engineering workstation network (EWS)
- Think and identify what are the uncertainties in your system behavior.
- How would you go about characterizing these uncertainties?
- What experiments would you run, how often, what background conditions would you assume, what parameters (identify at least two) would you measure?

# Final Project Topics

- Come up with ideas on how to use the concepts learned in the class to study the performance or reliability of the system.
- Example topics include:
  - Reliability/Performance evaluation
  - Random variables
  - Joint and conditional distributions
  - Special distributions:
    - Binomial, Geometric, Poisson, Gaussian, Exponential, etc.
  - Measuring mean, variance, co-variance, and correlation
  - Hypothesis testing
  - Mean time to failure, hazard rates, and failure densities
- You **must** do real or simulated measurements of the system.

# Final Project Deadlines

- **Individual meetings with each group, Thursday, Nov. 14**
  - In CSL 249, starting 12:30.
  - Write your name in one of the slots in the sign-up sheet
  - Come with some preliminary ideas on your project topic
- **First presentation (2 slides), next Thursday, Nov. 21:**
  - **Project goal and preliminary plan**
    - System under study
    - How to measure data
    - Techniques or concepts learned to apply
  - **Tasks for each group member**
  - **Timeline to finish the project**
- **Final project (report), due on the final exam date**
- **Final presentation, due the last day of the class**

# Hyperexponential Distribution

- A process with sequential phases gives rise to a hypoexponential or an Erlang distribution, depending upon whether or not the phases have identical distributions.
- If a process consists of alternate phases, i. e. during any single experiment the process experiences one and only one of the many alternate phases, **and**
- If these phases have independent exponential distributions, **then**
- The overall distribution is hyperexponential.

# Hyperexponential Distribution (cont.)

- The density function of a  $k$ -phase hyperexponential random variable is:

$$f(t) = \sum_{i=1}^k \alpha_i \lambda_i e^{-\lambda_i t}, \quad t > 0, \lambda_i > 0, \alpha_i > 0, \sum_{i=1}^k \alpha_i = 1$$

- The distribution function is:

$$F(t) = \sum_i \alpha_i (1 - e^{-\lambda_i t}), \quad t \geq 0$$

- The failure rate is:

$$h(t) = \frac{\sum \alpha_i \lambda_i e^{-\lambda_i t}}{\sum \alpha_i e^{-\lambda_i t}}, \quad t > 0$$

which is a decreasing failure rate from  $\sum \alpha_i \lambda_i$  down to  $\min \{\lambda_1, \lambda_2, \dots\}$

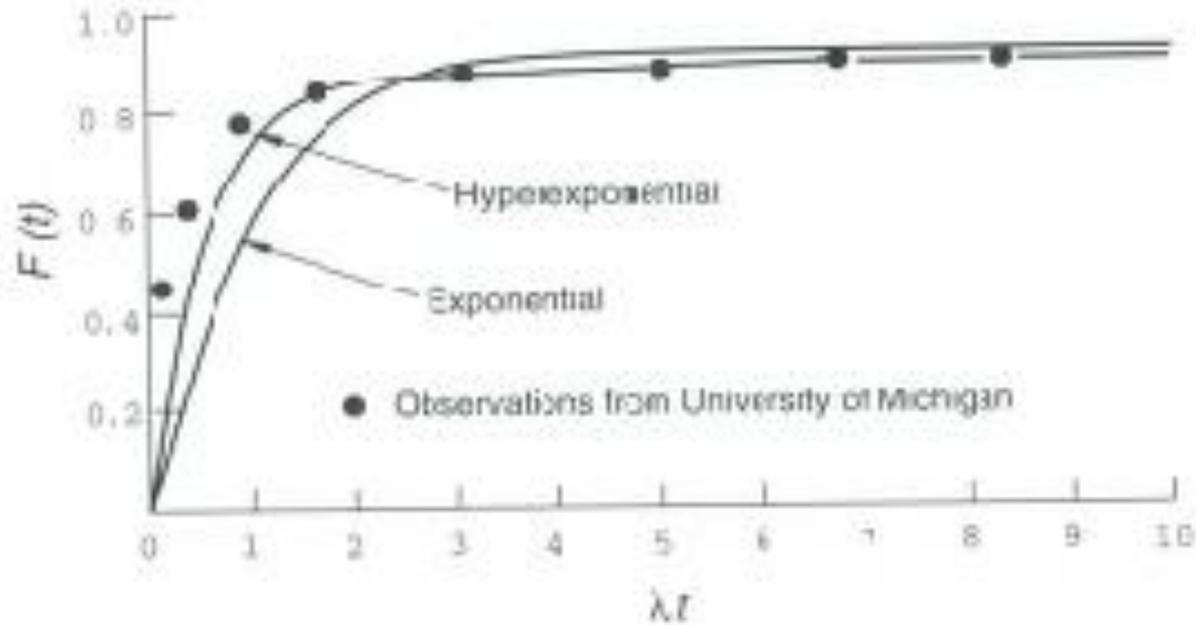
# Hyperexponential Distribution (cont.)

- The hyperexponential is a special case of mixture distributions that often arise in practice:

$$F(x) = \sum_i \alpha_i F_i(x), \quad \sum \alpha_i = 1, \alpha_i \geq 0$$

- The hyperexponential distribution exhibits more variability than the exponential, e.g. CPU service-time distribution in a computer system often expresses this.
- If a product is manufactured in several parallel assembly lines and the outputs are merged, then the failure density of the overall product is likely to be hyperexponential.

# Hyperexponential Distribution (cont.)



**Figure 3.13.** The CPU service time distribution compared with the hyperexponential distribution. (Reproduced from R. F. Rosin, "Determining a computing center environment," CACM, 1965; reprinted with permission of the Association of Computing Machinery.)

## Example 3 (On-line Fault Detector)

- Consider a model consisting of a functional unit (e.g., an adder) together with an on-line fault detector
- Let  $T$  and  $C$  denote the times to failure of the unit and the detector.
- After the unit fails, a finite time  $D$  (called the *detection latency*) is required to detect the failure.
- Failure of the detector, however, is detected instantaneously.

## Example 3 (On-line Fault Detector) cont.

- Let  $X$  denote the time to failure indication and  $Y$  denote the time to failure occurrence (of either the detector or the unit).

- Then

$$X = \min\{T + D, C\} \quad \text{and} \quad Y = \min\{T, C\}.$$

- If the detector fails before the unit, then a false alarm is said to have occurred.
- If the unit fails before the detector, then the unit keeps producing erroneous output during the detection phase and thus propagates the effect of the failure.
- The purpose of the detector is to reduce the detection time  $D$ .

## Example 3 (On-line Fault Detector) cont.

- We define:

***Real reliability***

$$R_r(t) = P(Y \geq t) \text{ and}$$

***Apparent reliability***

$$R_a(t) = P(X \geq t).$$

- A powerful detector will tend to narrow the gap between  $R_r(t)$  and  $R_a(t)$ .
- Assume that  $T$ ,  $D$ , and  $C$  are mutually independent and exponentially distributed with parameters  $\lambda$ ,  $\delta$ , and  $\alpha$ .

## Example 3 (On-line Fault Detector) cont.

- Then  $Y$  is *exponentially* distributed with parameter  $\lambda + \alpha$  and:

$$R_r(t) = e^{-(\lambda+\alpha)t}$$

- $T + D$  is *hypoexponentially* distributed so that:

$$F_{T+D}(t) = 1 - \frac{\delta}{\delta - \lambda} e^{-\lambda t} + \frac{\lambda}{\delta - \lambda} e^{-\delta t}$$

## Example 3 (On-line Fault Detector) cont.

- And, the apparent reliability is:

$$\begin{aligned}R_a(t) &= P(X \geq t) \\&= P(\min\{T + D, C\} \geq t) \\&= P(T + D \geq t \text{ and } C \geq t) \\&= P(T + D \geq t)P(C \geq t) \quad \text{by independence} \\&= [1 - F_{T+D}(t)]e^{-\alpha t} \\&= \frac{\delta}{\delta - \lambda} e^{-(\lambda + \alpha)t} - \frac{\lambda}{\delta - \lambda} e^{-(\delta + \alpha)t}\end{aligned}$$

# Phase-type Exponential Distributions

- Exponential Distribution:
  - Time to the event or Inter-arrivals => Poisson
- **Phase-type Exponential Distributions:**
- We have a process that is divided into  $k$  sequential phases, in which time that the process spends in each phase is:
  - Independent
  - Exponentially distributed
- The generalization of the phase-type exponential distributions is called **Coxian Distribution**
  - Any distribution can be expressed as the sum of phase-type exponential distributions

# Summary

Four special types of phase-type exponential distributions:

## 1) Hypoexponential Distribution:

- Exponential distributions at each phase have different  $\lambda$

## 2) K-stage Erlang Distribution:

- Exponential distributions in each phase are identical (with same  $\lambda$ )
- The number of phases ( $\alpha$ ) is an integer

## 3) Gamma Distribution

- Is a K-stage Erlang
- But the number of phases ( $\alpha$ ) is not an integer

## 4) Hyperexponential Distribution:

- A mixture of different exponential distributions